

Title (en)

METHOD FOR DETERMINING INFORMATION ON A HEAT-EXPOSED DEVICE

Title (de)

VERFAHREN ZUM ERMITTTELN EINER INFORMATION ÜBER EINE EINER TEMPERATUR AUSGESETZTEN VORRICHTUNG

Title (fr)

PROCEDE POUR DETERMINER UNE INFORMATION CONCERNANT UN DISPOSITIF SOUMIS A UNE TEMPERATURE

Publication

**EP 1817745 A1 20070815 (DE)**

Application

**EP 05797195 A 20051011**

Priority

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Abstract (en)

[origin: WO2006040316A1] The invention relates to a method for determining information on a heat-exposed device (1) which makes it possible to reliably and simply determine information of the device (1) deterioration. For this purpose, the device temperature is detected, at least one meter (5, 10) is incriminated according to an attainable temperature or temperature change. Information on the device (1) deterioration is determined according to the meter state.

IPC 8 full level

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